

An analytical method for 3-dimensional calculation of the contaminant X-ray dose in water caused by clinical electron-beam irradiation

Akira Iwasaki^{1*}, Shingo Terashima², Shigenobu Kimura³, Kohji Sutoh³, Kazuo Kamimura³, Yoichiro Hosokawa², and Masanori Miyazawa⁴

¹2-3-24 Shimizu, Hirosaki, Aomori 036-8254, Japan

²Graduate School of Health Sciences, Hirosaki University, 66-1 Hon-cho, Hirosaki, Aomori 036-8564, Japan

³Department of Radiology, Aomori City Hospital, 1-14-20 Katta, Aomori 030-0821, Japan

⁴Technology of Radiotherapy Corporation, 2-1-2 Koishikawa, Bunkyo-ku, Tokyo 175-0092, Japan

Abstract

Purposes: In this paper, an analytical method for 3-dimensional (3D) calculation of the contaminant X-ray dose in water caused by clinical electron-beam irradiation is proposed in light of the two groups of Monte Carlo (MC) datasets reported by Wieslander and Knöös (2006). **Methods:** The dose calculation was performed based on Clarkson's sector method. We used a plane called the isocenter plane, which is set perpendicular to the beam axis, containing the isocenter on it. On the isocenter plane, we defined the applicator field formed by an electron applicator and the cerrobend area field formed by a cerrobend insert if any, as well as other physical terms that are important for the dose calculations. The original sector method was modified to consider the following terms: (a) the vague beam-field margins formed by the dual-foil system; (b) the in-air dose distribution of the contaminant X-ray beam; (c) the X-ray spectrum change between the contaminant X-ray PDD datasets and the published radiotherapy X-ray PDD datasets; and (d) the contaminant X-ray attenuation for the cerrobend insert, if any. **Results and conclusions:** By comparing the calculated datasets of depth dose (DD) and off-axis dose (OAD) with the MC results for electron beams of $E=6, 12,$ and 18 MeV, it can be concluded that the analytical calculation method is of practical use for various irradiation conditions. In particular, it should be noted that the analytical method can give almost the same calculation results as the MC-based dose calculation algorithm used in a commercial treatment planning system (TPS).

Keywords: clinical electron-beams; contaminant X-ray dose; electron applicator; linear accelerator; scattering foil; Clarkson's sector method

Research highlights

Based on Clarkson's sector method, we developed an analytical method for calculation of the contaminant X-ray dose in water caused by clinical electron-beam irradiation. The analytical method was constructed by considering the following terms: (a) the vague beam-field margins formed by the dual-foil system; (b) the in-air dose distribution of the contaminant X-ray beam; (c) the X-ray spectrum change between the contaminant X-ray PDD datasets and the published radiotherapy X-ray PDD datasets; and (d) the contaminant X-ray attenuation for the cerrobend insert, if any. The dose calculation was performed in light of the two groups of Monte Carlo (MC) datasets reported by Wieslander and Knöös (2006). We conclude that the analytical method can achieve accurate dose calculations, even for beams with cerrobent inserts.

Introduction

Khan [1] describes the physical outline of high-energy electrons used in radiation therapy as follows: The most useful energy for electrons is 6 to 20 MeV. At these energies, the electron beams can be used to treat superficial tumors

(less than 5 cm deep) with a characteristically sharp drop-off in dose beyond the tumor. The principal applications are (a) the treatment of skin and lip cancers, (b) chest wall irradiation for breast cancer, (c) administering boost dose to nodes, and (d) the treatment of head and neck cancers. Although many of these sites can be treated with superficial X-rays, brachytherapy, or tangential photon beams, the electron-beam irradiation offers distinct advantages

***Corresponding authors:** Akira Iwasaki, 2-3-24 Shimizu, Hirosaki, Aomori 036-8254, Japan. Tel.: +172-33-2480; Email: fmch384@ybb.ne.jp or fmch384@gmail.com; and Shingo Terashima, Graduate School of Health Sciences, Hirosaki University, 66-1 Hon-cho, Hirosaki, Aomori 036-8564, Japan. Tel.: +81-172-39-5525; Email: s-tera@hirosaki-u.ac.jp

Received 20 November 2019 Revised 14 January 2020 Accepted 24 January 2020 Published 31 January 2020

Citation: Iwasaki A, Terashima S, Kimura S, Sutoh K, Kamimura K, Hosokawa Y, Miyazawa M. An analytical method for 3-dimensional calculation of the contaminant X-ray dose in water caused by clinical electron-beam irradiation. J Radiol Imaging. 2020; 4(2):7-16. DOI: [10.14312/2399-8172.2020-2](https://doi.org/10.14312/2399-8172.2020-2)

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(in rectangles). Because the X-ray collimator jaws give rise to extensive electron scattering, they are interlocked with the individual electron applicators to open automatically to a fixed predetermined size.

It should be stressed that the contaminant X-rays are primarily generated in the S_1 foil, and the amount of the contaminant X-rays varies in general with the field size (or electron applicator opening). We use a simple assumption here that the contaminant X-rays are all produced at a point (S'_1) on the isocenter axis within the S_1 foil, as shown in Figure 1 (this paper does not directly refer to the dose caused by the bremsstrahlung produced by the electrons running through the phantom). This diagram also shows a geometrical arrangement for the contaminant X-ray dose calculation using a semi-infinite water phantom whose surface coincides with the isocenter plane on which the isocenter (O) is situated. Let SSD_x be the distance between the S'_1 point and the isocenter (O), and let SSD_a be the distance between the S'_1 point and the beam exit side of the electron applicator. Furthermore, we set orthogonal coordinates of X_{beam} , Y_{beam} and Z_{beam} whose origin is placed at the isocenter (O), where the X_{beam} and Y_{beam} axes are set on the isocenter plane, and the Z_{beam} axis is drawn down from the isocenter (O), coinciding with the isocenter axis (or the beam axis). Let the dose calculation be performed at an arbitrary point $P(X_{cal}, Y_{cal}, Z_{cal})$ within the water phantom, defined as

$$R_{cal} = \sqrt{X_{cal}^2 + Y_{cal}^2}. \quad (\text{Eq. 1})$$

Let the intersection of the line S'_1P and the isocenter plane be denoted $Q(X_{iso}, Y_{iso})$ (S'_1P is one of the fanlines radiating from point S'_1), defined as

$$R_{iso} = \sqrt{X_{iso}^2 + Y_{iso}^2}. \quad (\text{Eq. 2})$$

Let Z_0 be the water length of point P , measured from point $Q(X_{iso}, Y_{iso})$ along the line S'_1P ; then, we have

$$Z_0 = \sqrt{(X_{cal} - X_{iso})^2 + (Y_{cal} - Y_{iso})^2 + Z_{cal}^2}. \quad (\text{Eq. 3})$$

The present analytical method is constructed for calculation of the contaminant X-ray dose at point $Q(X_{iso}, Y_{iso})$, which is based on Clarkson's sector method [1], described as follows:

(a) Let E be the electron-beam energy (MeV). Here, it is assumed that the contaminant X-rays are all produced in the S_1 foil by the E -MeV electrons coming out from the accelerator with an acceleration voltage of E (MV).

(b) We utilize published radiotherapy X-ray percentage depth dose (PDD) datasets for a source-surface distance (SSD) of 100 cm. Here, we use $Z_{max}(E)$ as the depth of maximum dose, letting it be simply determined only by E (MV) around a field of $10 \times 10 \text{ cm}^2$.

(c) Let the contaminant X-ray dose calculation be performed in a semi-infinite water phantom placed at an SSD of 100 cm, assuming that the dose is under lateral electron equilibrium and that the contaminant X-ray beam

intensity in air at $SSD=100 \text{ cm}$ is the in-air dose measured in a small mass of water under forward and lateral electron equilibrium.

(d) We use electron applicators forming rectangular beam fields (the dose calculations are performed by neglecting the fine structures of the applicators). Let $A_{appl} = S_{appl}^x \times S_{appl}^y$ be denoted as the beam field measured at the beam exit side of the electron applicator. Let A_{appl}^{iso} be the beam field measured on the isocenter plane. As the A_{appl}^{iso} field is shaped by the fanlines emanating from the S'_1 point, the A_{appl}^{iso} field can be described as

$$A_{appl}^{iso} = (SSD_x/SSD_a)S_{appl}^x \times (SSD_x/SSD_a)S_{appl}^y. \quad (\text{Eq. 4})$$

Conversely, we let A_{jaw}^{iso} be the field size that the X-ray collimator jaws form on the isocenter plane. As described earlier, we have $A_{jaw}^{iso} > A_{appl}^{iso}$. Therefore, it can be seen that the more accurate intensity of the contaminant X-ray beam should be evaluated [1] based on A_{jaw}^{iso} . This paper uses cerrobend inserts only within the electron applicator field (this is because the W-K MC dose datasets are all collected under such irradiation conditions). It should be noted that the W-K MC dose datasets are produced with $SSD_x=100 \text{ cm}$ and $SSD_a = 95 \text{ cm}$ using $A_{appl} = 10 \times 10, 14 \times 14, \text{ and } 20 \times 20 \text{ cm}^2$ (these dimensions are defined at $SSD=SSD_a$ [7]) for $E=6, 12, \text{ and } 18 \text{ MeV}$.

(e) Let $X_{output}^{center}(A_{appl}^{iso}, E)$ be the relative in-air dose intensity (refer to (c)) of the contaminant X-ray beam of E at the isocenter (O) when using an electron applicator of A_{appl} with no cerrobend insert.

(f) Let $X_{att}(T_{cerro}, E)$ be the attenuation factor for the contaminant X-ray beam of E for a cerrobend insert with a thickness of T_{cerro} ($X_{att} \leq 1$, setting $X_{att}(T_{cerro} = 0, E) = 1$).

(g) For calculation of the relative in-air dose for the contaminant X-ray beam of E with no beam shielding insert for a point of $Q(X_{iso}, Y_{iso})$ on the isocenter plane, we utilize the following function:

$$F_0(R_{iso}, E) = \exp[-f_0(E)R_{iso}]. \quad (\text{Eq. 5})$$

The relative in-air dose calculation for any combination of A_{appl} and E is then simply performed symmetrically with respect to the isocenter (O) on the isocenter plane, taking $F_0(R_{iso}=0, E)=1$. Because the jaw field (A_{jaw}^{iso}) determined by the electron applicator field (A_{appl}^{iso}) forms a perfect or approximate square field, the above F_0 function is practically reasonable for use.

(h) The W-K MC dose datasets show that, for the contaminant X-ray beams, the off-axis dose (OAD) curves (or the dose profiles along lines perpendicular to the isocenter axis) at any depth do not sharply change around the field border of the electron applicator and around the field border of the cerrobend insert (as illustrated in Figure C1(b) in Appendix C). Consequently, it has been found that, on the isocenter plane, there is a need to introduce special factors for each sector with respect to the field borders of the electron applicator and the cerrobend insert as follows:

For one of the \vec{R}_k lines ($k = 1, 2, 3, \dots$) extending radically on the isocenter plane from point Q (refer to Figures 2-6,

given later), if the corresponding \vec{R}_k line intersects the field border of the electron applicator or the cerrobend insert at distances of $\vec{R}_{k,1}, \vec{R}_{k,2}, \vec{R}_{k,3},$ etc., measured from point Q , it is necessary to set the special factors of interest for $\vec{R}_{k,i}$ ($i = 1,2,3,\dots$) as

$$H_0(R_{k,i}, E) = h_0(E)R_{k,i}^{\alpha(E)}. \tag{Eq. 6}$$

Moreover, it has been found (Figures C1 (a) and (b)) that $\alpha(E)=1$ is a good and simple model for any contaminant X-ray beam energy (E) and for any electron applicator field ($A_{\text{appl}}^{\text{iso}}$). It should be noted that the present paper does not directly use the $h_0(E)$ function.

(i) When using Clarkson’s sector method, we assume that, on the isocenter plane, a square field with a side of S is equivalent to a circular field with a radius of $R = S/\sqrt{\pi}$. The present paper utilizes this assumption for both the PDD function and the SF function taking the field size measured on the isocenter plane.

(j) For each energy E , the W-K MC dose datasets are expressed using the normalized valuation obtained when a common virtual accelerator is set up to deliver 1.0 Gy per 100 MU at a depth of d_{max} on the isocenter axis in water, where d_{max} is the depth at which the maximum dose caused by the electron-beam irradiation with an open electron applicator of $A_{\text{appl}}=20\times 20$ cm² is yielded (this means that the W-K MC dose datasets are all expressed in Gy/100 MU for each electron beam). Conversely, the present analytical dose calculation is performed for contaminant X-ray beams, based on published radiotherapy X-ray PDD datasets. Therefore, when comparing the analytical and MC datasets for each combination of A_{appl} and E , we need to take into account the X-ray spectrum difference between the contaminant X-ray beam and the published radiotherapy PDD X-ray beam, and we should introduce a conversion factor of $CF_{\text{MC/PDD}}$ (Gy/100MU/%) for setting both datasets at the same dose valuation level. However, the present study does not directly use the $CF_{\text{MC/PDD}}$ factor for the dose calculation.

(k) Under the assumption that the contaminant X-rays are all emitted from the S'_1 point at a distance of $SSD_x=100$ cm from the isocenter (O) along the isocenter axis (Figure 1), we may suppose that there is no change in PPD with SSD between the contaminant X-ray PDD function of $SSD_x=100$ cm and the published radiotherapy X-ray PDD function [8, 9] with $SSD_0 = 100$ cm (the following PDD functions are described under $SSD_0 = SSD_x = 100$ cm). For a given dose evaluation depth Z_0 , taking $A_{\text{appl}}^{\text{iso}}$ as a beam field on the isocenter plane, we let the published radiotherapy X-ray PDD function be expressed as $PDD_0 = PDD_0(Z_0, A_{\text{appl}}^{\text{iso}}, E)$, and let the contaminant X-ray PDD function be expressed as $PDD_x = PDD_x(Z_0, A_{\text{appl}}^{\text{iso}}, E)$.

(l) It has been found that the contaminant X-ray PDD_x can be approximated as follows:

For $Z_0 < Z_{\text{max}}(E)$,

$$PDD_x(Z_0, A_{\text{appl}}^{\text{iso}}, E) = 100 - Q_a(E) \cdot U_0(S_{\text{appl}}^{\text{iso}}) \cdot (1 - Z_0/Z_{\text{max}}(E))^{V_0(E)}, \tag{Eq. 7}$$

letting $S_{\text{appl}}^{\text{iso}}$ be the equivalent square field side of $A_{\text{appl}}^{\text{iso}}$, where

$$U_0(S_{\text{appl}}^{\text{iso}}) = 7.991 \times 10^1 \exp(-2.458 \times 10^{-2} S_{\text{appl}}^{\text{iso}}), \tag{Eq. 8}$$

$$V_0(E) = 4.426 \exp(-8.728 \times 10^{-3} E). \tag{Eq. 9}$$

Next, for $Z_0 \geq Z_{\text{max}}(E)$,

$$PDD_x(Z_0, A_{\text{appl}}^{\text{iso}}, E) = PDD_0(Z_0, A_{\text{appl}}^{\text{iso}}, E) \cdot \exp[-Q_b(E) \cdot (Z_0 - Z_{\text{max}}(E))^{\beta(E)}]. \tag{Eq. 10}$$

Here, the pair of $Q_a(E)$ and $V_0(E)$ and the pair of $Q_b(E)$ and $\beta(E)$ are introduced to consider the X-ray spectrum change between the PDD_x and PDD_0 X-ray beams of energy E .

(m) Figure 2 shows two arrangements for point $Q(X_{\text{iso}}, Y_{\text{iso}})$ on the isocenter plane. One is set in the $A_{\text{appl}}^{\text{iso}}$ field, and the other is outside the $A_{\text{appl}}^{\text{iso}}$ field. For the dose calculation relating to each Q point using Clarkson’s sector method, we take the \vec{R}_k line with an inclination angle θ_k radiating from point Q on the isocenter plane, setting $\theta_k = (k - 1) \Delta\theta_0 + \Delta\theta_0/2$ ($k = 1 - 360$) with $\Delta\theta_0 = 2\pi/360$ (radian), taken as anticlockwise rotation angles measured from the X_{beam} axis direction.

(n) Based on the above preconditions, we describe how to calculate the dose for point $P(X_{\text{cal}}, Y_{\text{cal}}, Z_{\text{cal}})$ by summing up each dose element (ΔD) obtained from the corresponding sector of \vec{R}_k and $\Delta\theta_0$. Figure 2 shows the case containing no cerrobend insert ($T_{\text{cerro}} = 0$). Let \vec{L}_j ($j = 1 - 4$) be the line vectors for the sides of the $A_{\text{appl}}^{\text{iso}}$ field, taking the rectangular field corners anticlockwise as ①, ②, ..., ⑤.

First, we set point $Q(X_{\text{iso}}, Y_{\text{iso}})$ inside the $A_{\text{appl}}^{\text{iso}}$ field, letting the \vec{R}_k line intersect with the $A_{\text{appl}}^{\text{iso}}$ field side of \vec{L}_4 as an example, and letting the distance between the point Q and the intersection point be $R_{k,1}$. Then, we can calculate the dose of ΔD as

$$\begin{aligned} \Delta D(X_{\text{cal}}, Y_{\text{cal}}, Z_{\text{cal}}) &= \frac{\vec{L}_4 \times \vec{R}_k}{|\vec{L}_4 \times \vec{R}_k|} \cdot CF_{\text{MC/PDD}}(A_{\text{appl}}^{\text{iso}}, E) \cdot \\ &X_{\text{att}}(T_{\text{cerro}} = 0, E) \cdot SF(R_{k,1}) \cdot \\ &PDD_x(Z_0, R_{k,1}, E) \cdot X_{\text{output}}^{\text{center}}(A_{\text{appl}}^{\text{iso}}, E) \cdot \\ &\exp[-f_0(A_{\text{appl}}^{\text{iso}}, E)R_{\text{iso}}] \cdot h_0(E)R_{k,1}^{\alpha(E)} \cdot \frac{\Delta\theta_0}{2\pi}, \tag{Eq. 11} \end{aligned}$$

where $\vec{L}_4 \times \vec{R}_k / |\vec{L}_4 \times \vec{R}_k| = 1$ and $X_{\text{att}}(T_{\text{cerro}} = 0, E) = 1$ (refer to (f)); $SF(R_{k,1})$ is the scatter factor (SF), evaluated using $R_{k,1}$ as the field radius (the SF can be set not as a function of E for MV photon beams [8]); and $PDD_x(Z_0, R_{k,1}, E)$ is expressed using the field radius of $R_{k,1}$. It should be emphasized that the term $h_0(E)R_{k,1}^{\alpha(E)}$ is introduced to take into account the vague beam-field margin formed by the dual-foil system. We can then rewrite equation 11 as

$$\begin{aligned} \Delta D(X_{\text{cal}}, Y_{\text{cal}}, Z_{\text{cal}}) &= \frac{\vec{L}_4 \times \vec{R}_k}{|\vec{L}_4 \times \vec{R}_k|} \cdot FAC(A_{\text{appl}}^{\text{iso}}, T_{\text{cerro}} = 0, E) \cdot SF(R_{k,1}) \cdot \\ &PDD_x(Z_0, R_{k,1}, E) \cdot \exp[-f_0(A_{\text{appl}}^{\text{iso}}, E)R_{\text{iso}}] \cdot R_{k,1}^{\alpha(E)} \cdot \frac{\Delta\theta_0}{2\pi}, \tag{Eq. 12} \end{aligned}$$

with

$$\begin{aligned} FAC(A_{\text{appl}}^{\text{iso}}, T_{\text{cerro}} = 0, E) &= CF_{\text{MC/PDD}}(A_{\text{appl}}^{\text{iso}}, E) \cdot h_0(E) \cdot X_{\text{output}}^{\text{center}}(A_{\text{appl}}^{\text{iso}}, E) \cdot \\ X_{\text{att}}(T_{\text{cerro}} = 0, E). \tag{Eq. 13} \end{aligned}$$

As described later, we will attempt to evaluate the FAC function in one lump for a given irradiation condition.

(o) Second, we set point $Q(X_{iso}, Y_{iso})$ outside the A_{app}^{iso} field (Figure 2). Then, the \vec{R}_k line concerns the sector dose calculation at two distances $R_{k,1}$ and $R_{k,2}$ from point Q . Let the \vec{R}_k line intersect with the electron applicator field sides \vec{L}_2 and \vec{L}_4 as an example. We can then calculate the dose of ΔD as

$$\begin{aligned} \Delta D(X_{cal}, Y_{cal}, Z_{cal}) &= \frac{\vec{L}_2 \times \vec{R}_k}{|\vec{L}_2 \times \vec{R}_k|} \cdot \text{FAC}(A_{app}^{iso}, T_{cerro} = 0, E) \cdot \text{SF}(R_{k,1}) \cdot \\ &\text{PDD}_X(Z_0, R_{k,1}, E) \cdot \exp[-f_0(A_{app}^{iso}, E)R_{iso}] \cdot \\ &R_{k,1}^{\alpha(E)} \cdot \frac{\Delta\theta_0}{2\pi} + \frac{\vec{L}_4 \times \vec{R}_k}{|\vec{L}_4 \times \vec{R}_k|} \cdot \\ &\text{FAC}(A_{app}^{iso}, T_{cerro} = 0, E) \cdot \text{SF}(R_{k,2}) \cdot \\ &\text{PDD}_X(Z_0, R_{k,2}, E) \cdot \exp[-f_0(A_{app}^{iso}, E)R_{iso}] \cdot R_{k,2}^{\alpha(E)} \\ &\frac{\Delta\theta_0}{2\pi} \end{aligned} \quad (\text{Eq. 14})$$

where $\vec{S}_2 \times \vec{R}_k / |\vec{S}_2 \times \vec{R}_k| = -1$ and $\vec{S}_4 \times \vec{R}_k / |\vec{S}_4 \times \vec{R}_k| = 1$.

It should be emphasized that, when the \vec{R}_k line does not intersect with the A_{app}^{iso} field sides, we need to calculate the relational sector dose as $\Delta D(X_{cal}, Y_{cal}, Z_{cal}) = 0$. This fact shows one of the defects for the present sector method. However, it has been found that the $\alpha(E)$ function can effectively deal with such dose calculation defects, as shown in the off-axis dose (OAD) curves calculated in the next section.

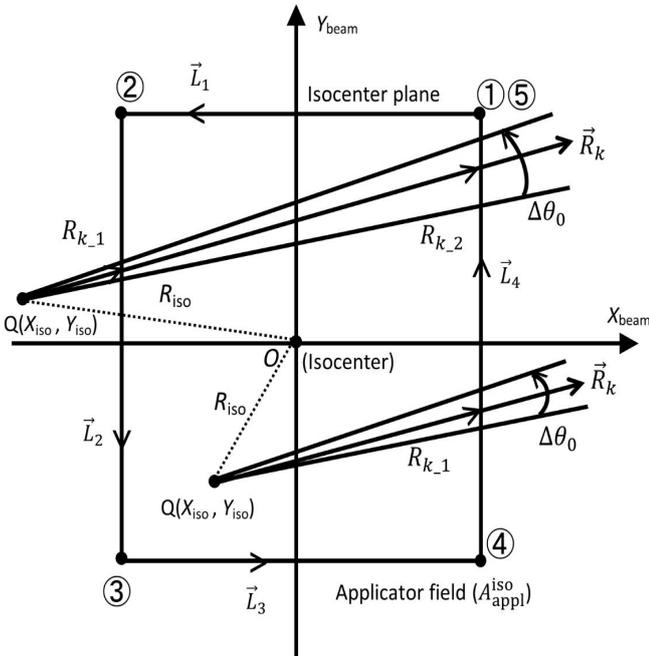


Figure 2 Diagram showing two arrangements for point $Q(X_{iso}, Y_{iso})$ on the isocenter plane. One is set in the A_{app}^{iso} field, and the other is outside the A_{app}^{iso} field. The dose calculation relating to each $Q(X_{iso}, Y_{iso})$ point is performed on the isocenter plane under Clarkson's sector method using the line vectors of \vec{R}_k with $\Delta\theta_0$, and using the line vectors of \vec{L}_j ($j=1-4$) for the A_{app}^{iso} field. The numbers ①, ②, ..., ⑤ proceed anticlockwise from a corner of the A_{app}^{iso} field (the positions of ① and ⑤ are the same).

(p) Figure 3 shows another irradiation case, in which a cerrobend insert with a hollow region in itself is set within an A_{app}^{iso} field. Then, we take points at distances of $R_{k,1}$, $R_{k,2}$, etc., measured from point $Q(X_{iso}, Y_{iso})$ along the \vec{R}_k line, depending on the position. Figure 4 shows a case in which point Q is placed in the hollow region of the cerrobend insert, where \vec{L}_j ($j=1, 2, \dots, 10$) are straight continuous lines forming the cerrobend insert shape anticlockwise (the numbers ①, ②, ..., ⑩ start from a point on the outside border of the cerrobend insert). Then, the dose ΔD from one sector of \vec{R}_k and $\Delta\theta_0$ within the cerrobend area can be similarly calculated as

$$\begin{aligned} \Delta D(X_{cal}, Y_{cal}, Z_{cal}) &= \frac{\vec{L}_1 \times \vec{R}_k}{|\vec{L}_1 \times \vec{R}_k|} \cdot \text{FAC}(A_{app}^{iso}, T_{cerro}, E) \cdot \text{SF}(R_{k,2}) \cdot \\ &\text{PDD}_X(Z_0, R_{k,2}, E) \cdot \exp[-f_0(A_{app}^{iso}, E)R_{iso}] \cdot \\ &R_{k,2}^{\alpha(E)} \cdot \frac{\Delta\theta_0}{2\pi} + \frac{\vec{L}_9 \times \vec{R}_k}{|\vec{L}_9 \times \vec{R}_k|} \cdot \text{FAC}(A_{app}^{iso}, T_{cerro}, E) \cdot \\ &\text{SF}(R_{k,1}) \cdot \text{PDD}_X(Z_0, R_{k,1}, E) \cdot \\ &\exp[-f_0(A_{app}^{iso}, E)R_{iso}] \cdot R_{k,1}^{\alpha(E)} \cdot \frac{\Delta\theta_0}{2\pi} \end{aligned} \quad (\text{Eq. 15})$$

with

$$\begin{aligned} \text{FAC}(A_{app}^{iso}, T_{cerro}, E) &= \text{CF}_{MC/PDD}(A_{app}^{iso}, E) \cdot h_0(E) \cdot \\ &X_{output}^{center}(A_{app}^{iso}, E) \cdot X_{att}(T_{cerro}, E). \end{aligned} \quad (\text{Eq. 16})$$

Subsequently, we attempt to calculate the dose from the regions outside the cerrobend area.

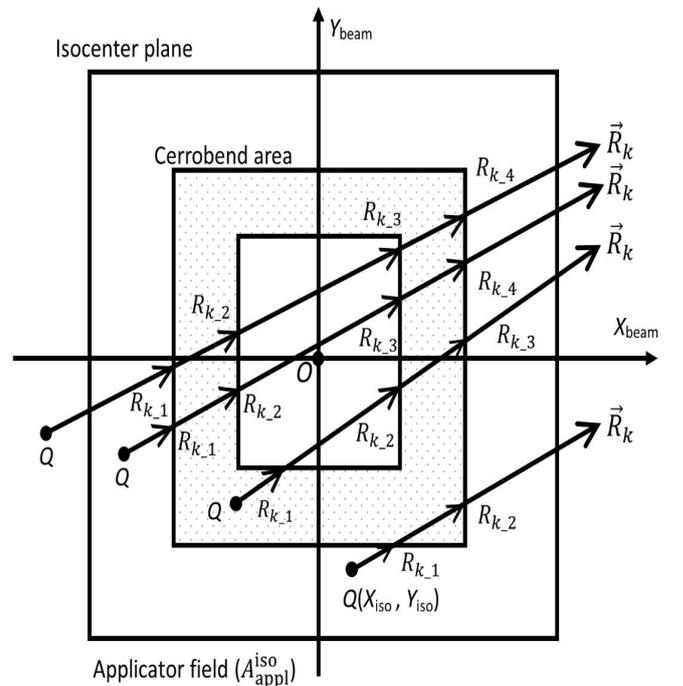


Figure 3 Diagram showing how to take points $R_{k,1}$, $R_{k,2}$, etc., along the R_k line starting from point $Q(X_{iso}, Y_{iso})$, depending on the position for an irradiation case in which a cerrobend insert with a hollow region in itself is set within an A_{app}^{iso} field.

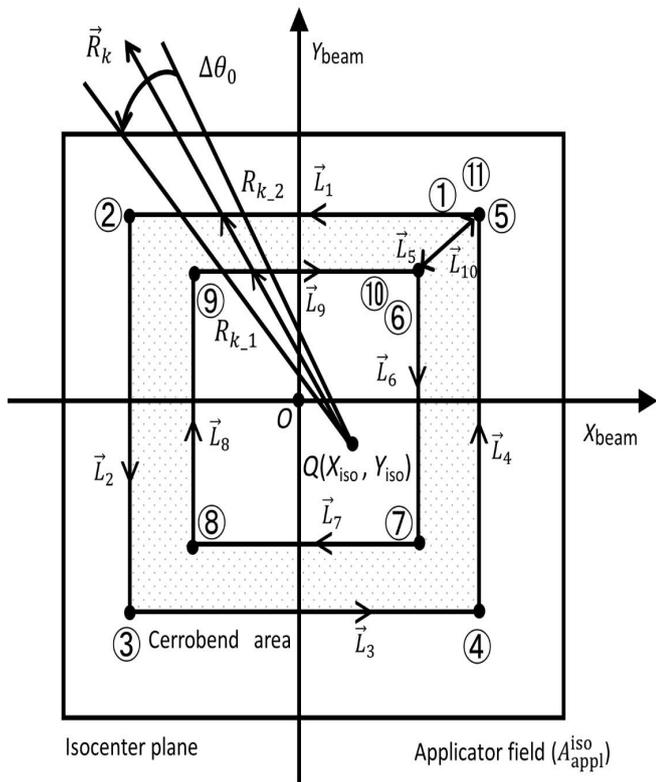


Figure 4 Diagram showing a case in which point $Q(X_{iso}, Y_{iso})$ is placed in the hollow region of a cerrobend insert for calculation of the dose from the cerrobend area. \vec{L}_j ($j=1, 2, \dots, 10$) are line vectors forming the cerrobend area, taken anticlockwise with the numbers ①, ②, ..., ⑩ starting from a corner of the outside border of the cerrobend area (the positions of ① and ⑩ are at the same).

Figure 5 shows how to take points at distances of $R_{k,1}$, $R_{k,2}$, etc., measured from point $Q(X_{iso}, Y_{iso})$ along the \vec{R}_k line, depending on the position. Referring to Figure 6, in which point Q is set in the hollow region of the cerrobend insert, the dose ΔD from one sector of \vec{R}_k and $\Delta\theta_0$ can be calculated as

$$\begin{aligned} \Delta D(X_{cal}, Y_{cal}, Z_{cal}) &= \frac{\vec{L}_1 \times \vec{R}_k}{|\vec{L}_1 \times \vec{R}_k|} \cdot \text{FAC}(A_{\text{appl}}^{\text{iso}}, T_{\text{cerro}} = 0, E) \cdot \\ &\text{PDD}_X(Z_0, R_{k,3}, E) \cdot \text{SF}(R_{k,3}) \cdot \exp[-f_0(A_{\text{appl}}^{\text{iso}}, E)R_{\text{iso}}] \cdot R_{k,3}^{\alpha(E)} \cdot \frac{\Delta\theta_0}{2\pi} \\ &+ \frac{\vec{L}_9 \times \vec{R}_k}{|\vec{L}_9 \times \vec{R}_k|} \cdot \text{FAC}(A_{\text{appl}}^{\text{iso}}, T_{\text{cerro}} = 0, E) \cdot \text{PDD}_X(Z_0, R_{k,2}, E) \cdot \\ &\text{SF}(R_{k,2}) \cdot \exp[-f_0(A_{\text{appl}}^{\text{iso}}, E)R_{\text{iso}}] \cdot R_{k,2}^{\alpha(E)} \cdot \frac{\Delta\theta_0}{2\pi} \\ &+ \frac{\vec{L}_{11} \times \vec{R}_k}{|\vec{L}_{11} \times \vec{R}_k|} \cdot \text{FAC}(A_{\text{appl}}^{\text{iso}}, T_{\text{cerro}} = 0, E) \cdot \text{PDD}_X(Z_0, R_{k,1}, E) \cdot \\ &\text{SF}(R_{k,1}) \cdot \exp[-f_0(A_{\text{appl}}^{\text{iso}}, E)R_{\text{iso}}] \cdot R_{k,1}^{\alpha(E)} \cdot \frac{\Delta\theta_0}{2\pi}, \end{aligned} \quad (\text{Eq. 17})$$

where $\vec{L}_1 \times \vec{R}_k / |\vec{L}_1 \times \vec{R}_k| = 1$, $\vec{L}_9 \times \vec{R}_k / |\vec{L}_9 \times \vec{R}_k| = -1$, and $\vec{L}_{11} \times \vec{R}_k / |\vec{L}_{11} \times \vec{R}_k| = 1$.

(q) Finally, we reassess the factor X_{att} using equations 13 and 16. This is given by

$$X_{\text{att}}(T_{\text{cerro}}, E) = \frac{\text{FAC}(A_{\text{appl}}^{\text{iso}}, T_{\text{cerro}}, E)}{\text{FAC}(A_{\text{appl}}^{\text{iso}}, T_{\text{cerro}} = 0, E)}. \quad (\text{Eq. 18})$$

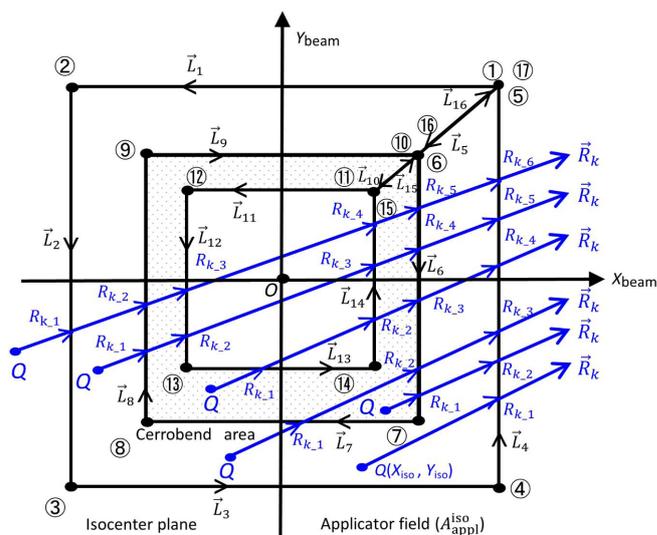


Figure 5 Diagram used for calculation of the dose from the regions outside the cerrobend area, showing how to take points $R_{k,1}$, $R_{k,2}$, etc., on the \vec{R}_k line starting from point $Q(X_{iso}, Y_{iso})$ depending on the position. \vec{L}_j ($j=1, 2, \dots, 16$) are line vectors forming the area not covered with the cerrobend area, taken anticlockwise with the numbers ①, ②, ..., ⑰ starting from a corner of the $A_{\text{appl}}^{\text{iso}}$ field (the positions of ① and ⑰ are at the same).

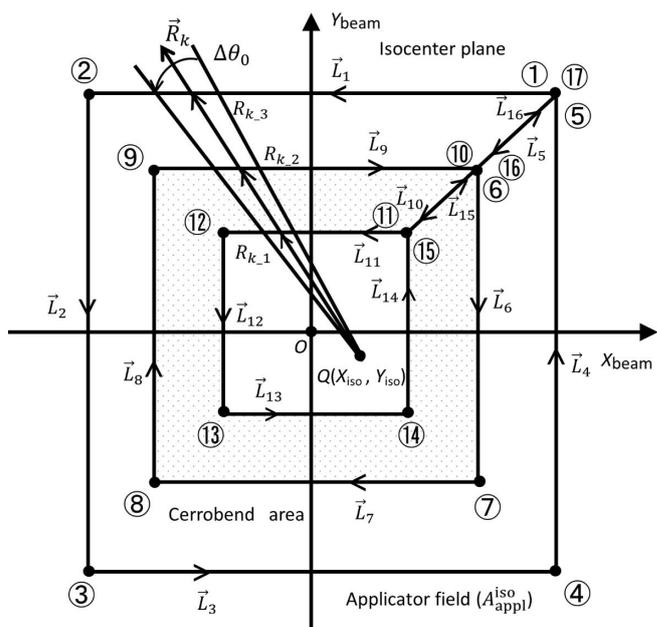


Figure 6 Diagram used for calculation of the dose from the regions outside the cerrobend area for the case in which point $Q(X_{iso}, Y_{iso})$ is set in the hollow region of the cerrobend insert. Both the line vectors of \vec{L}_j ($j=1, 2, \dots, 16$) and the numbers ①, ②, ..., ⑰ are the same as in Figure 5.

Correspondence with the W-K MC dose datasets

The W-K MC dose datasets are produced using a common virtual accelerator for two MC simulation techniques: one is performed with BEAMnrc [10, 11] as the dose calculation simulation using a Cartesian voxel grid with the DOSXYZnrc code [12-14] as the phantom simulation (let the combination of these simulations be called the standard simulation technique); the other is performed using the MC-based dose calculation simulation in a commercial TPS.

The W-K MC dose datasets are performed in water phantoms for $E=6, 12,$ and 18 MeV using $A_{\text{appl}}=10 \times 10 \text{ cm}^2$, $A_{\text{appl}}=10 \times 10/14 \times 14 \text{ cm}^2$ (where 10×10 is the field produced using a cerrobend insert placed just inside the 14×14 applicator), and $A_{\text{appl}}=20 \times 20 \text{ cm}^2$. The dose datasets are separated into depth dose (DD) curves and off-axis dose (OAD or profile-dose) curves, which are normalized with the dose obtained when the virtual accelerator is set up to deliver 1.0 Gy per 100 MU at the maximum dose depth (d_{max}) in water using $A_{\text{appl}}=20 \times 20 \text{ cm}^2$ for each electron-beam energy (E). The dose datasets acquired using the standard simulation technique are composed of stepped curves of DD and OAD; and the dose datasets acquired using the commercial TPS are composed of dotted curves of DD and OAD. It should be noted that both the stepped and dotted datasets of OAD are classified as OAD profiles in the X and Y directions; however, the present paper does not refer to the OAD differences in the X and Y directions.

Results and discussion

The functions and constants used for each of the DD and OAD calculations were determined by trial and error. Table 1 summarizes values for the functions and constants, excluding $\alpha(E)=1$, $U_0(A_{\text{appl}}^{\text{iso}})$ as given by equation 8, and $V_0(E)$ as given by equation 9. Table 1 is classified into four groups: (a) the stepped curves of DD (Case-1 to -8), (b) the stepped curves of OAD (Case-9 to -16), (c) the dotted curves of DD (Case-17 to -24), and (d) the dotted curves of OAD (Case-25 to -32). For each case number, the corresponding reference datasets are given using figure numbers of the W-K MC dose work as follows:

Regarding the group (a),

- Case-1 ($A_{\text{appl}}=10 \times 10 \text{ cm}^2$, $E=6$ MeV) is for DD in Figure 3(a) under OAD in Figure 2(b);
 Case-2 ($A_{\text{appl}}=10 \times 10 \text{ cm}^2$, $E=6$ MeV) is for DD in Figure 3(a) under OAD in Figure 3(b);
 Case-3 ($A_{\text{appl}}=10 \times 10 \text{ cm}^2$, $E=6$ MeV) is for DD in Figure 3(a) under OAD in Figure 3(c);
 Case-4 ($A_{\text{appl}}=10 \times 10/14 \times 14 \text{ cm}^2$, $E=12$ MeV) is for DD in Figure 5(a) under OAD in Figure 5(b);
 Case-5 ($A_{\text{appl}}=10 \times 10/14 \times 14 \text{ cm}^2$, $E=12$ MeV) is for DD in Figure 5(a) under OAD in Figure 5(c);
 Case-6 ($A_{\text{appl}}=10 \times 10 \text{ cm}^2$, $E=18$ MeV) is for DD in Figure 3(d) under OAD in Figure 2(b);
 Case-7 ($A_{\text{appl}}=10 \times 10 \text{ cm}^2$, $E=18$ MeV) is for DD in Figure 3(d) under OAD in Figure 3(e);
 Case-8 ($A_{\text{appl}}=10 \times 10 \text{ cm}^2$, $E=18$ MeV) is for DD in Figure 3(d) under OAD in Figure 3(f).

Regarding the group (b),

- Case-9 ($A_{\text{appl}}=20 \times 20 \text{ cm}^2$, $E=6$ MeV) is for OAD ($Z_{\text{cal}}=5$ cm) in Figure 2(b) under DD in Figure 3(a);
 Case-10 ($A_{\text{appl}}=20 \times 20 \text{ cm}^2$, $E=6$ MeV) is for OAD ($Z_{\text{cal}}=1$ cm) in Figure 3(b) under DD in Figure 3(a);
 Case-11 ($A_{\text{appl}}=20 \times 20 \text{ cm}^2$, $E=6$ MeV) is for OAD ($Z_{\text{cal}}=5$ cm) in Figure 3(c) under DD in Figure 3(a);
 Case-12 ($A_{\text{appl}}=10 \times 10/14 \times 14 \text{ cm}^2$, $E=12$ MeV) is for OAD ($Z_{\text{cal}}=2$ cm) in Figure 5(b) under DD in Figure 5(a);

- Case-13 ($A_{\text{appl}}=10 \times 10/14 \times 14 \text{ cm}^2$, $E=12$ MeV) is for OAD ($Z_{\text{cal}}=10$ cm) in Figure 5(c) under DD in Figure 5(a);
 Case-14 ($A_{\text{appl}}=20 \times 20 \text{ cm}^2$, $E=18$ MeV) is for OAD ($Z_{\text{cal}}=15$ cm) in Figure 2(b) under DD in Figure 3(d);
 Case-15 ($A_{\text{appl}}=10 \times 10 \text{ cm}^2$, $E=18$ MeV) is for OAD ($Z_{\text{cal}}=3$ cm) in Figure 3(e) under DD in Figure 3(d);
 Case-16 ($A_{\text{appl}}=10 \times 10 \text{ cm}^2$, $E=18$ MeV) is for OAD ($Z_{\text{cal}}=15$ cm) in Figure 3(f) under DD in Figure 3(d).

Regarding the group (c),

- Case-17 ($A_{\text{appl}}=10 \times 10 \text{ cm}^2$, $E=6$ MeV) is for DD in Figure 3(a) under OAD in Figure 2(b);
 Case-18 ($A_{\text{appl}}=10 \times 10 \text{ cm}^2$, $E=6$ MeV) is for DD in Figure 3(a) under OAD in Figure 3(b);
 Case-19 ($A_{\text{appl}}=10 \times 10 \text{ cm}^2$, $E=6$ MeV) is for DD in Figure 3(a) under OAD in Figure 3(c);
 Case-20 ($A_{\text{appl}}=10 \times 10/14 \times 14 \text{ cm}^2$, $E=12$ MeV) is for DD in Figure 5(a) under OAD in Figure 5(b);
 Case-21 ($A_{\text{appl}}=10 \times 10/14 \times 14 \text{ cm}^2$, $E=12$ MeV) is for DD in Figure 5(a) under OAD in Figure 5(c);
 Case-22 ($A_{\text{appl}}=10 \times 10 \text{ cm}^2$, $E=18$ MeV) is for DD in Figure 3(d) under OAD in Figure 2(b);
 Case-23 ($A_{\text{appl}}=10 \times 10 \text{ cm}^2$, $E=18$ MeV) is for DD in Figure 3(d) under OAD in Figure 3(e);
 Case-24 ($A_{\text{appl}}=10 \times 10 \text{ cm}^2$, $E=18$ MeV) is for DD in Figure 3(d) under OAD in Figure 3(f).

Regarding the group (d),

- Case-25 ($A_{\text{appl}}=20 \times 20 \text{ cm}^2$, $E=6$ MeV) is for OAD ($Z_{\text{cal}}=5$ cm) in Figure 2(b) under DD in Figure 3(a);
 Case-26 ($A_{\text{appl}}=10 \times 10 \text{ cm}^2$, $E=6$ MeV) is for OAD ($Z_{\text{cal}}=1$ cm) in Figure 3(b) under DD in Figure 3(a);
 Case-27 ($A_{\text{appl}}=10 \times 10 \text{ cm}^2$, $E=6$ MeV) is for OAD ($Z_{\text{cal}}=5$ cm) in Figure 3(c) under DD in Figure 3(a);
 Case-28 ($A_{\text{appl}}=10 \times 10/14 \times 14 \text{ cm}^2$, $E=12$ MeV) is for OAD ($Z_{\text{cal}}=2$ cm) in Figure 5(b) under DD in Figure 5(a);
 Case-29 ($A_{\text{appl}}=10 \times 10/14 \times 14 \text{ cm}^2$, $E=12$ MeV) is for OAD ($Z_{\text{cal}}=10$ cm) in Figure 5(c) under DD in Figure 5(a);
 Case-30 ($A_{\text{appl}}=20 \times 20 \text{ cm}^2$, $E=18$ MeV) is for OAD ($Z_{\text{cal}}=15$ cm) in Figure 2(b) under DD in Figure 3(d);
 Case-31 ($A_{\text{appl}}=10 \times 10 \text{ cm}^2$, $E=18$ MeV) is for OAD ($Z_{\text{cal}}=3$ cm) in Figure 3(e) under DD in Figure 3(d);
 Case-32 ($A_{\text{appl}}=10 \times 10 \text{ cm}^2$, $E=18$ MeV) is for OAD ($Z_{\text{cal}}=15$ cm) in Figure 3(f) under DD in Figure 3(d).

Table 1 also lists values of $Z_{\text{max}}(E)$, Applicator (A_{appl} & $S_{\text{appl}}^{\text{iso}}$ = equivalent square field side of $A_{\text{appl}}^{\text{iso}}$), $Q_a(E)$, $Q_b(E)$, $\beta(E)$, $f_0(E)$, $\text{FAC}(A_{\text{appl}}^{\text{iso}}, T_{\text{cerro}}=0, E)$, $\text{FAC}(A_{\text{appl}}^{\text{iso}}, T_{\text{cerro}} > 0, E)$, and $X_{\text{att}}(T_{\text{cerro}} \geq 0, E)$.

By analyzing the datasets of the stepped curves of DD and OAD (Case-1 to -16) regarding the functions of $Q_a(E)$, $Q_b(E)$, $\beta(E)$, and $f_0(E)$, we constructed the following regression equations:

$$Q_a(E) = 9.519 \times 10^{-1} \exp(7.946 \times 10^{-3} E), \quad (\text{Eq. 19})$$

$$Q_b(E) = 9.033 \times 10^{-4} \exp(9.646 \times 10^{-2} E), \quad (\text{Eq. 20})$$

$$\beta(E) = 1.951 \exp(-2.160 \times 10^{-2} E), \quad (\text{Eq. 21})$$

$$f_0(E) = 5.003 \times 10^{-3} \exp(1.319 \times 10^{-1} E). \quad (\text{Eq. 22})$$

Conversely, for the FAC function, we used $S_{\text{appl}}^{\text{iso}}$ and E as variables (letting $S_{\text{appl}}^{\text{iso}}$ be defined as the equivalent square field side of $A_{\text{appl}}^{\text{iso}}$). By analyzing the FAC datasets of Case-1 to -16, we constructed a FAC regression function of

$$\begin{aligned} \text{FAC}(S_{\text{appl}}^{\text{iso}}, T_{\text{cerro}} = 0, E) &= 1.124 \times 10^{-5} \exp(-5.064 \times 10^{-2} S_{\text{appl}}^{\text{iso}}) \cdot \\ &\exp(1.281 \times 10^{-1} E). \end{aligned} \tag{Eq. 23}$$

Similarly, for the dotted curves of DD and OAD under Case-17 to -32, we built the following regression equations:

$$Q_a(E) = 1.711 \exp(-3.169 \times 10^{-2} E), \tag{Eq. 24}$$

$$Q_b(E) = 3.209 \times 10^{-5} \exp(4.534 \times 10^{-1} E), \tag{Eq. 25}$$

$$\beta(E) = 4.333 \exp(-1.053 \times 10^{-1} E), \tag{Eq. 26}$$

$$f_0(E) = 2.302 \times 10^{-2} \exp(1.686 \times 10^{-2} E), \tag{Eq. 27}$$

$$\text{FAC}(S_{\text{appl}}^{\text{iso}}, T_{\text{cerro}} = 0, E) = 9.436 \times 10^{-6} \exp(-4.835 \times 10^{-2} S_{\text{appl}}^{\text{iso}}) \cdot \exp(1.483 \times 10^{-1} E). \tag{Eq. 28}$$

These regression functions may be useful for estimating reasonable values for the corresponding functions for given irradiation conditions. Details are described in Appendix A. Further in Appendix B, we refer to detailed results for calculated and MC-based DD and OAD datasets; and in Appendix C, we refer to the working of the function $\alpha(E)$.

Table 1 Values of the functions and constants used for the contaminant X-ray depth dose (DD) and off-axis dose (OAD) calculations under the conditions of , as given by equation 8, and as given by equation 9.

(a) Obtained based on the stepped curves of DD (Case-1 to -8) in the W-K MC dose datasets.

Case-no. E (MeV)	$Z_{\text{max}}(E)$ (cm)	Applicator ($A_{\text{appl}}/\text{cm}^2$)	$Q_a(E)$	$Q_b(E)$	$\beta(E)$	$f_0(E)$ (cm^{-1})	$\text{FAC}(A_{\text{appl}}^{\text{iso}}, T_{\text{cerro}} E)$ (for $T_{\text{cerro}}=0$)	$\text{FAC}(A_{\text{appl}}^{\text{iso}}, T_{\text{cerro}} E)$ (for $T_{\text{cerro}} > 0$)	$\chi_{\text{att}}(T_{\text{cerro}} E)$ (for $T_{\text{cerro}} \geq 0$)
Case-1 $E=6$ MeV	1.5	10 x 10 ($S_{\text{appl}}^{\text{iso}} = 10.5$ cm)	1.000	9.428E-04	1.946	2.638E-03	1.287E-05	no existing	1
Case-2 $E=6$ MeV	1.5	10 x 10 ($S_{\text{appl}}^{\text{iso}} = 10.5$ cm)	1.000	9.428E-04	1.946	4.411E-03	1.287E-05	no existing	1
Case-3 $E=6$ MeV	1.5	10 x 10 ($S_{\text{appl}}^{\text{iso}} = 10.5$ cm)	1.000	9.428E-04	1.946	3.819E-02	1.287E-05	no existing	1
Case-4 $E=12$ MeV	2.6	10x10/14x14 ($S_{\text{appl}}^{\text{iso}} = 14.7$ cm)	1.043	1.097E-02	1.097	4.401E-02	3.123E-05	1.875E-05	0.600
Case-5 $E=12$ MeV	2.6	10x10/14x14 ($S_{\text{appl}}^{\text{iso}} = 14.7$ cm)	1.043	1.097E-02	1.097	3.264E-02	3.205E-05	1.722E-05	0.537
Case-6 $E=18$ MeV	3.2	10 x 10 ($S_{\text{appl}}^{\text{iso}} = 10.5$ cm)	1.100	3.000E-03	1.501	4.898E-02	5.993E-05	no existing	1
Case-7 $E=18$ MeV	3.2	10 x 10 ($S_{\text{appl}}^{\text{iso}} = 10.5$ cm)	1.100	3.000E-03	1.501	3.853E-02	5.993E-05	no existing	1
Case-8 $E=18$ MeV	3.2	10 x 10 ($S_{\text{appl}}^{\text{iso}} = 10.5$ cm)	1.100	3.000E-03	1.501	5.305E-02	5.993E-05	no existing	1

(b) Obtained based on the stepped curves of OAD (Case-9 to -16) in the W-K MC dose datasets.

Case-no. E (MeV)	$Z_{\text{max}}(E)$ (cm)	Applicator ($A_{\text{appl}}/\text{cm}^2$)	$Q_a(E)$	$Q_b(E)$	$\beta(E)$	$f_0(E)$ (cm^{-1})	$\text{FAC}(A_{\text{appl}}^{\text{iso}}, T_{\text{cerro}} E)$ (for $T_{\text{cerro}}=0$)	$\text{FAC}(A_{\text{appl}}^{\text{iso}}, T_{\text{cerro}} E)$ (for $T_{\text{cerro}} > 0$)	$\chi_{\text{att}}(T_{\text{cerro}} E)$ (for $T_{\text{cerro}} \geq 0$)
Case-9 $E=6$ MeV	1.5	20 x 20 ($S_{\text{appl}}^{\text{iso}} = 21.5$ cm)	1.000	9.428E-04	1.946	2.638E-03	6.495E-06	no existing	1
Case-10 $E=6$ MeV	1.5	10 x 10 ($S_{\text{appl}}^{\text{iso}} = 10.5$ cm)	1.000	9.428E-04	1.946	4.411E-03	1.335E-05	no existing	1
Case-11 $E=6$ MeV	1.5	10 x 10 ($S_{\text{appl}}^{\text{iso}} = 10.5$ cm)	1.000	9.428E-04	1.946	3.819E-02	1.433E-05	no existing	1
Case-12 $E=12$ MeV	2.6	10x10/14x14 ($S_{\text{appl}}^{\text{iso}} = 14.7$ cm)	1.043	1.097E-02	1.097	2.739E-02	3.084E-05	1.852E-05	0.600

(Table 1b Continued)

Case-13 E=12 MeV	2.6	10×10/14×14 (S _{appl} ^{iso} = 14.7 cm)	1.043	1.097E-02	1.097	4.287E-02	3.126E-05	1.679E-05	0.537
Case-14 E=18 MeV	3.2	20 x 20 (S _{appl} ^{iso} = 21.1 cm)	1.100	3.000E-03	1.501	4.898E-02	3.282E-05	no existing	1
Case-15 E=18 MeV	3.2	10 x 10 (S _{appl} ^{iso} = 10.5 cm)	1.100	3.000E-03	1.501	3.853E-02	6.424E-05	no existing	1
Case-16 E=18 MeV	3.2	10 x 10 (S _{appl} ^{iso} = 10.5 cm)	1.100	3.000E-03	1.501	5.305E-02	6.427E-05	no existing	1

(c) Obtained based on the dotted curves of DD (Case-17 to -24) in the W-K MC dose datasets.

Case-no. E (MeV)	Z _{max} (E) (cm)	Applicator (A _{appl} /cm ²)	Q _a (E)	Q _b (E)	β(E)	f ₀ (E) (cm ⁻¹)	FAC(A _{appl} ^{iso} T _{cerro} E) (for T _{cerro} =0)	FAC(A _{appl} ^{iso} T _{cerro} E) (for T _{cerro} > 0)	χ _{att} (T _{cerro} E) (for T _{cerro} ≥ 0)
Case-17 E=6 MeV	1.5	10 x 10 (S _{appl} ^{iso} = 10.5 cm)	1.400	3.428E-04	2.396	2.763E-02	1.291E-05	no existing	1
Case-18 E=6 MeV	1.5	10 x 10 (S _{appl} ^{iso} = 10.5 cm)	1.400	3.428E-04	2.396	3.017E-02	1.291E-05	no existing	1
Case-19 E=6 MeV	1.5	10 x 10 (S _{appl} ^{iso} = 10.5 cm)	1.400	3.428E-04	2.396	2.107E-02	1.291E-05	no existing	1
Case-20 E=12 MeV	2.6	10×10/14×14 (S _{appl} ^{iso} = 14.7 cm)	1.200	1.780E-02	1.110	2.975E-02	3.042E-05	1.319E-05	0.434
Case-21 E=12 MeV	2.6	10×10/14×14 (S _{appl} ^{iso} = 14.7 cm)	1.200	1.780E-02	1.110	2.477E-02	3.182E-05	1.010E-05	0.318
Case-22 E=18 MeV	3.2	10 x 10 (S _{appl} ^{iso} = 10.5 cm)	0.957	7.903E-02	0.677	5.659E-02	7.730E-05	no existing	1
Case-23 E=18 MeV	3.2	10 x 10 (S _{appl} ^{iso} = 10.5 cm)	0.957	7.903E-02	0.677	1.963E-02	7.730E-05	no existing	1
Case-24 E=18 MeV	3.2	10 x 10 (S _{appl} ^{iso} = 10.5 cm)	0.957	7.903E-02	0.677	3.751E-02	7.730E-05	no existing	1

(d) Obtained based on the dotted curves of OAD (Case-25 to -32) in the W-K MC dose datasets.

Case-no. E (MeV)	Z _{max} (E) (cm)	Applicator (A _{appl} /cm ²)	Q _a (E)	Q _b (E)	β(E)	f ₀ (E) (cm ⁻¹)	FAC(A _{appl} ^{iso} T _{cerro} E) (for T _{cerro} =0)	FAC(A _{appl} ^{iso} T _{cerro} E) (for T _{cerro} > 0)	χ _{att} (T _{cerro} E) (for T _{cerro} ≥ 0)
Case-25 E=6 MeV	1.5	20 x 20 (S _{appl} ^{iso} = 21.5 cm)	1.400	428E-04	2.396	2.763E-02	7.429E-06	no existing	1
Case-26 E=6 MeV	1.5	10 x 10 (S _{appl} ^{iso} = 10.5 cm)	1.400	3.428E-04	2.396	3.017E-02	1.463E-05	no existing	1
Case-27 E=6 MeV	1.5	10 x 10 (S _{appl} ^{iso} = 10.5 cm)	1.400	3.428E-04	2.396	2.107E-02	1.347E-05	no existing	1
Case-28 E=12 MeV	2.6	10×10/14×14 (S _{appl} ^{iso} = 14.7 cm)	1.200	1.780E-02	1.110	2.868E-02	2.963E-05	1.285E-05	0.434
Case-29 E=12 MeV	2.6	10×10/14×14 (S _{appl} ^{iso} = 14.7 cm)	1.200	1.780E-02	1.110	2.752E-02	3.199E-05	1.016E-05	0.318

(Table 1d Continued)

Case-30 E=18 MeV	3.2	20 x 20 ($S_{\text{appl}}^{\text{iso}}=21.1$ cm)	0.957	7.903E-02	0.677	5.659E-02	4.469E-05	no existing	1
Case-31 E=18 MeV	3.2	10 x 10 ($S_{\text{appl}}^{\text{iso}}=10.5$ cm)	0.957	7.903E-02	0.677	1.963E-02	7.577E-05	no existing	1
Case-32 E=18 MeV	3.2	10 x 10 ($S_{\text{appl}}^{\text{iso}}=10.5$ cm)	0.957	7.903E-02	0.677	3.751E-02	8.867E-05	no existing	1

Conclusions

We attempted to develop an analytical method for 3-dimensional (3D) calculation of the contaminant X-ray dose in water caused by clinical electron-beam irradiation in light of the two groups of Monte Carlo (MC) datasets reported by Wieslander and Knöös (2006). The analytical method is based on Clarkson's sector method. However, the original sector method was modified to take into account the following terms: (a) the vague beam-field margins formed by the dual-foil system; (b) the in-air dose distribution of the contaminant X-ray beam; (c) the difference between the X-ray spectrum used for constructing the contaminant X-ray PDD datasets and that used for constructing the published radiotherapy X-ray PDD datasets; and (d) the contaminant X-ray attenuation for the cerrobend insert, if any. We can conclude that the analytical method can achieve accurate dose calculations, even for beams with cerrobend inserts. In particular, it should be emphasized that the analytical method can give almost the same calculation results as the MC-based dose calculation algorithm in a commercial TPS.

Acknowledgements

We would like to thank Editage (www.editage.com) for English language editing.

Conflicts of interest

This study was carried out in collaboration with Technology of Radiotherapy Corporation, Tokyo, Japan. This sponsor had no control over the interpretation, writing, or publication of this work.

Supplementary data

Supplementary data (Appendix A, B & C) associated with this article can be found, at <http://dx.doi.org/10.14312/2399-8172.2020-2>.

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